

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/607,929	SRIVER ET AL.
	Examiner	Art Unit
	Le Nguyen	2174

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
US-PGPUB, USPAT: 715.827		11/12/06	LVN